



EMC TEST REPORT

Report No.: SET2015-17080

Product Name: Mobile phone

FCC ID: SG7201511L32

Model No.: HM-G351-FL/L32

Applicant: Haier Telecom (Qingdao) Co.,Ltd.

Address: No.1 Haier Road, Hi-tech Zone, Qingdao, China

Received Date: 2015-11-09

Tested Date: 2015-11-09—2015-11-23

Issued by: CCIC-SET

Lab Location: Electronic Testing Building, Shahe Road, Xili, Nanshan District,

Shenzhen, 518055, P. R. China

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CCIC-SET/T (00) Page 1 of 22





Test Report

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Product Name::	Mobile phone
Model No::	HM-G351-FL/L32
Applicant::	Haier Telecom (Qingdao) Co.,Ltd.
Applicant Address::	No.1 Haier Road, Hi-tech Zone, Qingdao, China
Manufacturer:	Haier Telecom (Qingdao) Co.,Ltd.
Manufacturer Address::	No.1 Haier Road, Hi-tech Zone, Qingdao, China
Test Standards::	47 CFR Part 15 Subpart B: Radio Frequency Devices
Test Result:	PASS
Tested by::	xiao long shang 2015.11.24
	Xiaolong Zhang, Test Engineer
Reviewed by::	Shuangwen zhang 2015.11.24
	Shuangwen Zhang, Senior Engineer
Approved by:	Wa lian 2015.11.24
	2015.11.24

CCIC-SET/T (00) Page 2 of 22

Wu Li'an, Manager



		TA	BLE OF CONTENTS	
1.	GENE	RAL INFORMATION		4
1.1	EUT I	Description		4
1.2				
1.3	Facilit	ies and Accreditations		6
1.3.1	Faci	lities		6
1.3.2	Test	Environment Conditions		6
1.3.3	Mea	surement Uncertainty		6
2.	TEST	CONDITIONS SETTIN	G	7
2.1	Test P	eripherals		7
2.2	Test M	Iode		7
2.3	Test So	etup and Equipments Lis	st	8
2.3.1	Cone	ducted Emission		8
2.3.2	Radi	ated Emission		8
3.	47 CF	R PART 15B REQUIRE	MENTS	11
3.1	Condu	icted Emission		11
3.1.1	Requ	uirement		11
3.1.2	Test	Description		11
3.1.3	Test	Result		11
3.2	Radia	ted Emission		14
3.2.1	Requ	uirement		14
3.2.2	Test	Description		15
3.2.3	Test	Result		15
4.	PHOT	OGRAPHS OF THE EU	T	20
5.	РНОТ	OGRAPHS OF THE TE	ST SET-UP	21
			Change History	
	Issue	Date	Reason for change	
	1.0	2015.11.24	First edition	





1. GENERAL INFORMATION

1.1 EUT Description

Trade Name : Haier
Brand Name : Haier
Hardware Version : H01
Software Version : V01
Power Supply : Battery

Brand Name: Haier
Model No.: H15393
Capacitance: 1950 mAh

Rated Voltage: 3.8V Charge Limit: 4.35V

Brand Name: Haier

Model No.: YSN05100CE76

Rated Input: 100-240V, 50/60Hz ,0.2A

Rated Output: 5V=1000mA

Note1: The EUT is a Mobile phone, it supports the following operating frequency band: GSM850/1900, WCDMA850/1700/1900, GPS,802.11b,802.11g,802.11n20/n40, Bluetooth4.0, LTE, band2,4,7, 17.

Note2:The EUT is equipped with a T-Flash card slot; equipped with a USB port which can be connected to the ancillary equipments.

Note 3:The highest operation frequency or processor operate frequency is 1GHz,so the measurement of radiated disturbance shall only be made up to 5GHz.

Note4:For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.

CCIC-SET/T (00) Page 4 of 22



1.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title		
1	47 CFR Part 15	Radio Frequency Devices		
	Subpart B 2014			

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Result
1	15.107	Conducted Emission	PASS
2	15.109	Radiated Emission	PASS

NOTE:

(1) The EUT has been tested according to 47 CFR Part 15 Subpart B,Class B.The test procedure is according to ANSI C63.4:2009.

CCIC-SET/T (00) Page 5 of 22



1.3 Facilities and Accreditations

1.3.1 Facilities

CNAS-Lab Code: L1659

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd. CCIC is a third party testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659. A 12.8*6.8*6.4 (m) fully anechoic chamber was used for the radiated spurious emissions test.

FCC-Registration No.: 406086

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 406086, valid time is until October 28, 2017.

1.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15°C - 35°C
Relative Humidity (%):	25% -75%
Atmospheric Pressure (kPa):	86kPa-106kPa

1.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	Uc = 3.6 dB (k=2)
Uncertainty of Radiated Emission:	Uc = 4.5 dB (k=2)

CCIC-SET/T (00) Page 6 of 22





2. TEST CONDITIONS SETTING

2.1 Test Peripherals

The following is a listing of the EUT and peripherals utilized during the performance of EMC test:

Description	escription Manufacturer		Serial No.	FCCID /DOC
Notebook	ThinkPad	E430C	A131101550	/
Micro SD card	SanDisk	/	/	/
Mouse	deiog	/	/	DOC

2.2 Test Mode

(1) The first test mode

The EUT configuration of the emission tests is <u>TransFlash Card + EUT + Battery + PC+ Earphone.</u>

In this test mode, the EUT with a TransFlash Card embedded is connected with a PC via a USB cable supplied by applicant. During the measurement, the data is transmitting between the PC and the TransFlash Card of the EUT.

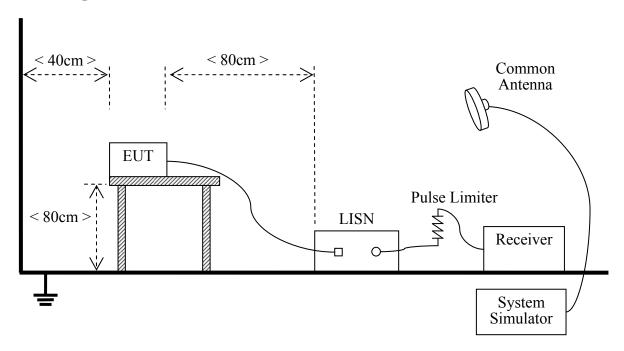
CCIC-SET/T (00) Page 7 of 22



2.3 Test Setup and Equipments List

2.3.1 Conducted Emission

A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu H$ of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

B. Equipments List:

Description	Manufacturer	Model	Serial No.	Calibration Date	Calibration Due. Date
Test Receiver	ROHDE&SCHWARZ	ESCI	A130901475	2015.09.09	2016.09.08
LISN	ROHDE&SCHWARZ	ENV216	/	2015.04.28	2016.04.27
Cable	MATCHING PAD	W7	/	2015.06.05	2016.06.04

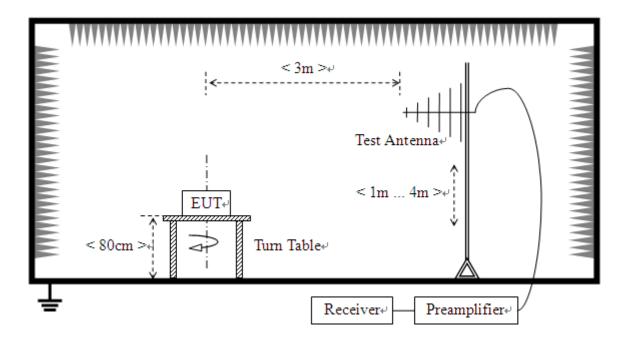
2.3.2 Radiated Emission

A. Test Setup:

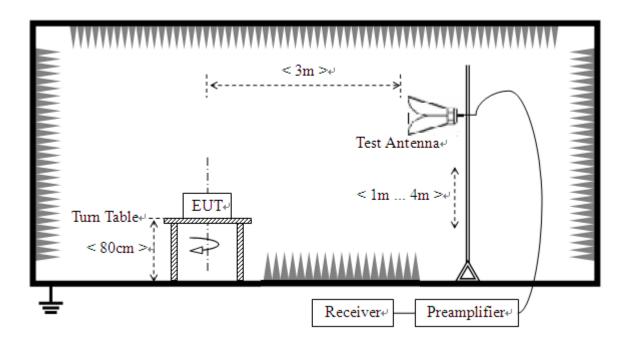
CCIC-SET/T (00) Page 8 of 22



1) For radiated emissions from 30MHz to1GHz



2) For radiated emissions above 1GHz



B. Test Procedure

The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a

CCIC-SET/T (00) Page 9 of 22





variable-height antenna master tower.

For the test Antenna:

1) In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

C. Equipments List:

Description	Manufacturer	Model	Serial No.	Calibration Date	Calibration Due. Date
Test Receiver	ROHDE&SCHWARZ	ESIB7	A0501375	2015.06.10	2016.06.09
Test Receiver	ROHDE&SCHWARZ	ESIB26	A0304218	2015.06.10	2016.06.09
Semi-Anechoic Chamber	Albatross	9m*6m*6m	A0412372	2015.03.22	2016.03.21
Test Antenna - Bi-Log	НР	CBL6111A	A9704202	2015.06.10	2016.06.09
Test Antenna – Horn	ROHDE&SCHWARZ	HF906	A0304225	2015.06.10	2016.06.09
Anechoic Chamber	Albatross	SAC-5MAC 12.8x6.8x6.4m	A0304210	2015.03.22	2016.03.21
Amplifier 1G~18GHz	ROHDE&SCHWARZ	MITEQ AFS42-001018 00	A0509366	2015.06.10	2016.06.09
Amplifier 20M~3GHz	Compliance Direction System	PAP-0203H	A0509377	2015.06.10	2016.06.09
Cable	SUNHNER	SUCOFLEX 100	/	2015.06.10	2016.06.09
Cable	SUNHNER	SUCOFLEX 104	MY1758/4	2015.06.10	2016.06.09

CCIC-SET/T (00) Page 10 of 22





3. 47 CFR PART 15B REQUIREMENTS

3.1 Conducted Emission

3.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a $50\mu H/50\Omega$ line impedance stabilization network (LISN).

E (MII-)	Conducted Limit (dBµV)			
Frequency range (MHz)	Quasi-peak	Average		
0.15 - 0.50	66 to 56	56 to 46		
0.50 - 5	56	46		
5 - 30	60	50		

NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50MHz.

3.1.2 Test Description

See section 2.3.1 of this report.

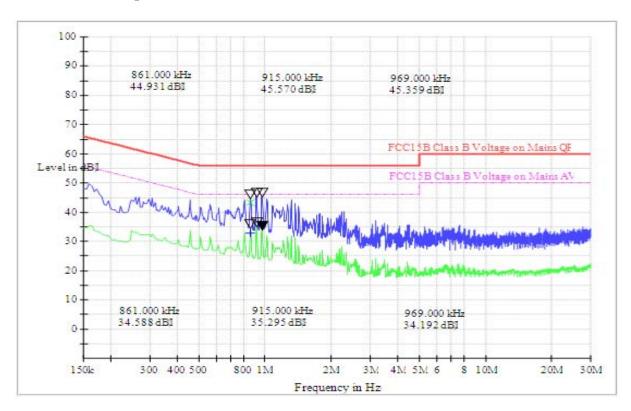
3.1.3 Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

CCIC-SET/T (00) Page 11 of 22



A. Test Plot and Suspicious Points:

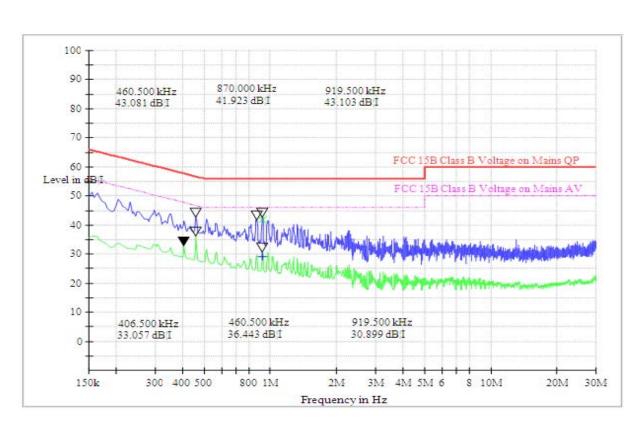


(Plot A: L Phase)

	Conducted Disturbance at Mains Terminals								
	L Test Data								
	QP AV								
$ \begin{array}{ c c c c c c } \hline Frequen & Limits & Measurem \\ cy & (dB\mu V) & ent Value \\ (MHz) & (dB\mu V) & (dB) \\ \hline \end{array} $				Frequen cy (MHz)	Limits (dBµV)	Measurem ent Value (dBμV)	Margin (dB)		
0.8610	56.00	43.20	12.80	0.8610	46.00	32.69	13.31		
0.9150	56.00	44.21	11.79	0.9150	46.00	34.06	11.94		
0.9690	56.00	44.18	11.82	0.9690	46.00	33.62	12.38		

CCIC-SET/T (00) Page 12 of 22





(Plot B: N Phase)

	Conducted Disturbance at Mains Terminals									
	N Test Data									
	QP AV									
Frequen cy (MHz)	Limits (dBµV)	Measureme nt Value (dBμV)	Margin (dB)	Frequency (MHz)	Limits (dBµV)	Measureme nt Value (dBµV)	Margin (dB)			
0.4605	56.70	42.31	14.39	0.4605	46.70	35.04	11.66			
0.8700	56.00	40.16	15.84	0.8700	46.00	28.24	17.76			
0.9190	56.00	42.34	13.66	0.9195	46.00	29.01	16.99			

Test Result: PASS

CCIC-SET/T (00) Page 13 of 22



3.2 Radiated Emission

3.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency	Field Strength		Field Strength Limitation at 3m Measurement Dist		
range (MHz)	μV/m	Dist	(uV/m)	(dBuV/m)	
0.009 - 0.490	2400/F(kHz)	300m	10000* 2400/F(kHz)	20log 2400/F(kHz) + 80	
0.490 - 1.705	2400/F(kHz)	30m	100* 2400/F(kHz)	20log 2400/F(kHz) + 40	
1.705 - 30.00	30	30m	100*30	20log 30 + 40	
30.0 - 88.0	100	3m	100	20log 100	
88.0 - 216.0	150	3m	150	20log 150	
216.0 - 960.0	200	3m	200	20log 200	
Above 960.0	500	3m	500	20log 500	

- a) As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.
- b) Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength.
- c) For below 1G:QP detector RBW 120kHz, VBW 300kHz.
- d) For Above 1G: PK detector RBW 1MHz,VBW 3MHz for PK value ;AV detector RBW 1MHz, VBW 10Hz for AV value.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dBuV/m is calculated by 20log Emission Level(uV/m).
- 3) If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of Ld1 = Ld2 * $(d2/d1)^2$.

Example:

F.S Limit at 30m distance is 30uV/m, then F.S Limitation at 3m distance is adjusted as Ld1 = L1 = $30uV/m * (10)^2 = 100 * 30uV/m$.

CCIC-SET/T (00) Page 14 of 22



3.2.2 Test Description

See section 2.3.2 of this report.

3.2.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions which are attenuated more than 20 dB below the permissible value need not be reported.

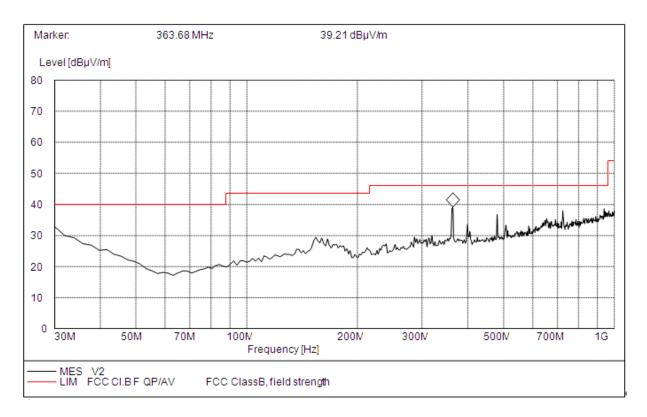
Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

CCIC-SET/T (00) Page 15 of 22



B. Test Plots and Suspicious Points:

Test result of radiated emission below 1GHz

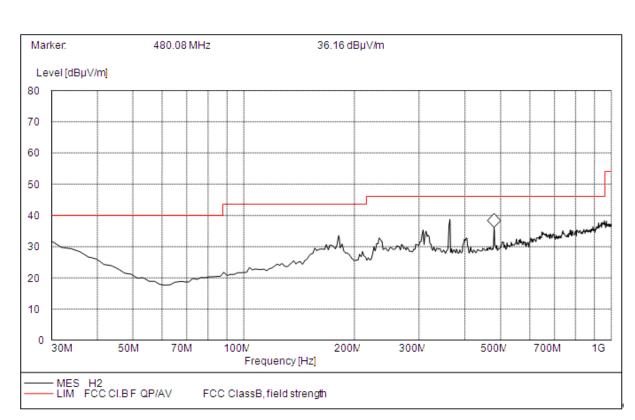


(Plot C: Test Antenna Vertical 30M - 1G)

Frequency (MHz)	QuasiPeak (dB µ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB µ V/m)	Margin (dB)	Antenna	Verdict
30.04000	30.21	120.000	153.0	40.00	9.79	Vertical	Pass
363.05000	37.42	120.000	247.0	46.00	8.58	Vertical	Pass
480.36000	34.08	120.000	162.0	46.00	11.92	Vertical	Pass

CCIC-SET/T (00) Page 16 of 22





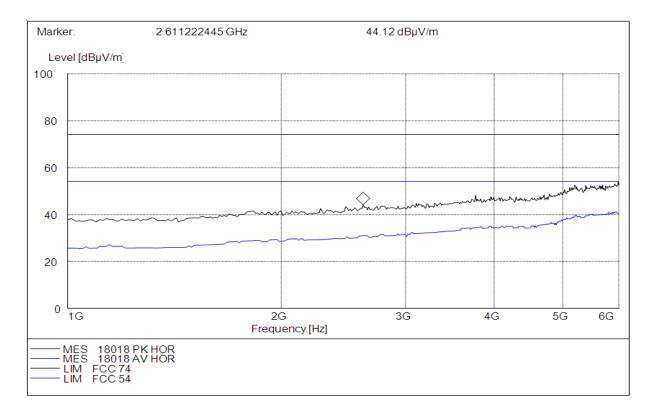
(Plot D: Test Antenna Horizontal 30M - 1G)

Frequency (MHz)	QuasiPeak (dBμV/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dBµV/m)	Margin (dB)	Antenna	Verdict
181.36000	31.24	120.000	219.0	43.50	12.26	Horizontal	Pass
363.28000	35.16	120.000	179.0	46.00	10.84	Horizontal	Pass
480.23100	34.04	120.000	147.0	46.00	11.96	Horizontal	Pass

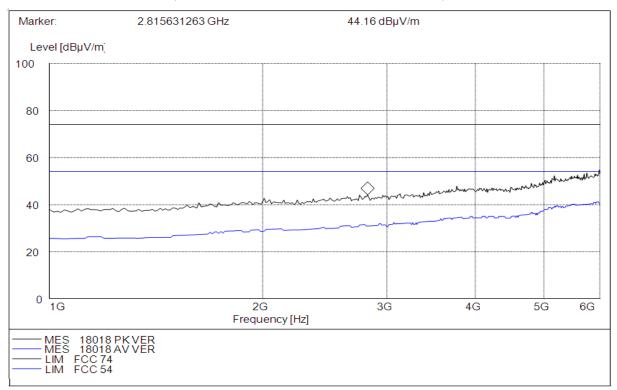
CCIC-SET/T (00) Page 17 of 22



Test result of radiated emission above 1GHz



(Plot E: Test Antenna Horizontal 1G – 6G)



(Plot F: Test Antenna Vertical 1G – 6G)

CCIC-SET/T (00) Page 18 of 22



Note: The test result margin of radiated emission above 1GHz is more than 20dB.
Test Result: PASS

CCIC-SET/T (00) Page 19 of 22



4. PHOTOGRAPHS OF THE EUT

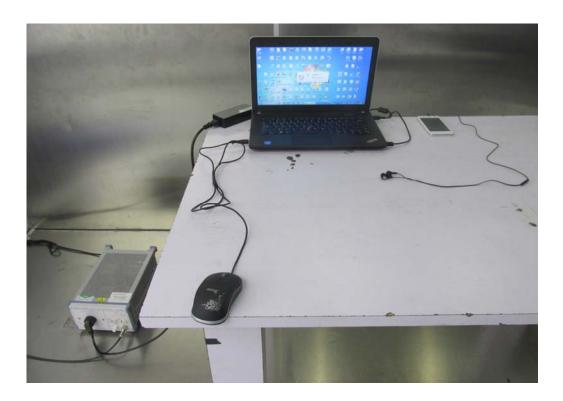




CCIC-SET/T (00) Page 20 of 22



5. PHOTOGRAPHS OF THE TEST SET-UP



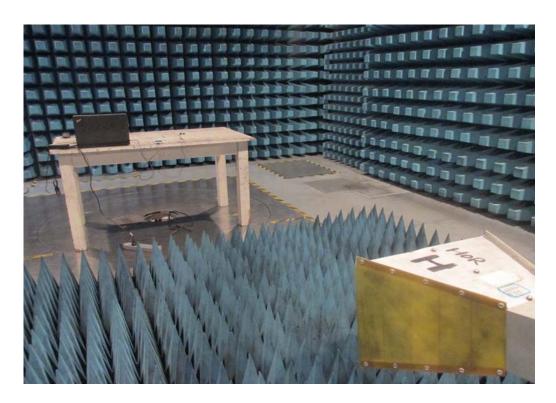
Conducted Emission



Radiated Emission of 30M-1G

CCIC-SET/T (00) Page 21 of 22





Radiated Emission of 1-6G

** END OF REPORT **

CCIC-SET/T (00) Page 22 of 22